

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



## Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China









# STF15N95K5, STP15N95K5, STW15N95K5

N-channel 950 V, 0.41 Ω typ., 12 A SuperMESH™ 5 Power MOSFETs in TO-220FP, TO-220 and TO-247 packages

Datasheet - production data

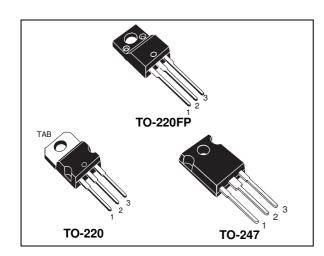
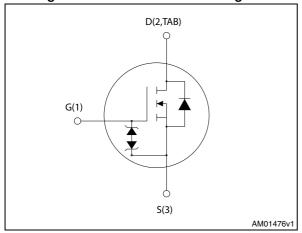


Figure 1. Internal schematic diagram



#### **Features**

Order codes	V <sub>DS</sub>	R <sub>DS(on)max</sub>	I <sub>D</sub>	P <sub>TOT</sub>
STF15N95K5				30 W
STP15N95K5	950 V	$0.5~\Omega$	12 A	170 W
STW15N95K5				170 00

- TO-220 worldwide best R<sub>DS(on)</sub>
- Worldwide best FOM (figure of merit)
- Ultra low gate charge
- 100% avalanche tested
- Zener-protected

### **Applications**

Switching applications

#### **Description**

These devices are N-channel Power MOSFETs developed using SuperMESH™ 5 technology. This revolutionary, avalanche-rugged, high voltage Power MOSFET technology is based on an innovative proprietary vertical structure. The result is a drastic reduction in on-resistance and ultra low gate charge for applications which require superior power density and high efficiency.

Table 1. Device summary

Order codes	Marking	Package	Packaging
STF15N95K5	15N95K5	TO-220FP	
STP15N95K5	15N95K5	TO-220	Tube
STW15N95K5	15N95K5	TO-247	

## **Contents**

1	Electrical ratings
2	Electrical characteristics
	2.1 Electrical characteristics (curves)
3	Test circuits
4	Package mechanical data
5	Revision history

## 1 Electrical ratings

Table 2. Absolute maximum ratings

		Va	lue	
Symbol	Parameter	TO-220 TO-247	TO-220FP	Unit
$V_{GS}$	Gate- source voltage	±	30	V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	12	12 <sup>(1)</sup>	Α
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	7.6	7.6 <sup>(1)</sup>	Α
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	48	48 <sup>(1)</sup>	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	170	30	W
I <sub>AR</sub>	Max current during repetitive or single pulse avalanche (pulse width limited by T <sub>jmax</sub> )		4	А
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_J = 25$ °C, $I_D = I_{AS}$ , $V_{DD} = 50$ V)	1:	24	mJ
ESD	Gate-source human body model (R= 1,5 k $\Omega$ , C = 100 pF)	:	2	kV
V <sub>ISO</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s;T <sub>C</sub> =25 °C)		2500	V
dv/dt (3)	Peak diode recovery voltage slope	4	.5	V/ns
dv/dt (4)	MOSFET dv/dt ruggedness	5	60	V/ns
T <sub>j</sub> T <sub>stg</sub>	Operating junction temperature Storage temperature	-55 to	o 150	°C

<sup>1.</sup> Limited by maximum junction temperature.

Table 3. Thermal data

Symbol	Parameter	Value			Unit
Symbol	Faranietei	TO-220	TO-247	TO-220FP	5
R <sub>thj-case</sub>	Thermal resistance junction-case max	0.	74	4.2	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-amb max	62.5	50	62.5	°C/W

<sup>2.</sup> Pulse width limited by safe operating area.

<sup>3.</sup>  $I_{SD} \leq 12$ , di/dt  $\leq 100 \text{ A}/\mu\text{s}$ ,  $V_{DS(peak)} \leq V_{(BR)DSS}$ 

<sup>4.</sup>  $V_{DS} \leq 760 V$ 

### 2 Electrical characteristics

(T<sub>CASE</sub> = 25 °C unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	I <sub>D</sub> = 1 mA, V <sub>GS</sub> = 0	950			٧
1	Zero gate voltage drain	V <sub>DS</sub> = 950 V,			1	μΑ
I <sub>DSS</sub>	current (V <sub>GS</sub> = 0)	V <sub>DS</sub> = 950 V, Tc=125 °C			50	μΑ
I <sub>GSS</sub>	Gate body leakage current (V <sub>DS</sub> = 0)	V <sub>GS</sub> = ± 20 V			±10	μΑ
$V_{GS(th)}$	Gate threshold voltage	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$	3	4	5	٧
R <sub>DS(on)</sub>	Static drain-source on-resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 6 A		0.41	0.50	Ω

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>iss</sub>	Input capacitance		-	855	-	pF
C <sub>oss</sub>	Output capacitance	V <sub>DS</sub> =100 V, f=1 MHz, V <sub>GS</sub> =0	ı	65		pF
C <sub>rss</sub>	Reverse transfer capacitance	20 7 20	-	1		pF
C <sub>o(tr)</sub> <sup>(1)</sup>	Equivalent capacitance time related	$V_{GS} = 0$ , $V_{DS} = 0$ to 760 V	-	104	-	pF
C <sub>o(er)</sub> <sup>(2)</sup>	Equivalent capacitance energy related	V <sub>GS</sub> = 0, V <sub>DS</sub> = 0 to 700 V	ı	38	1	pF
R <sub>G</sub>	Intrinsic gate resistance	f = 1 MHz open drain	-	6	-	Ω
Qg	Total gate charge	V <sub>DD</sub> = 760 V, I <sub>D</sub> = 12 A	-	30	-	nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> =10 V	-	5	-	nC
$Q_{gd}$	Gate-drain charge	(see Figure 20)	-	22	-	nC

<sup>1.</sup> Time related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 

<sup>2.</sup> energy related is defined as a constant equivalent capacitance giving the same stored energy as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(v)</sub>	Voltage delay time		-	23	-	ns
t <sub>r(v)</sub>	Voltage rise time	$V_{DD} = 475 \text{ V}, I_{D} = 6 \text{ A}, R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$	-	20	-	ns
t <sub>f(i)</sub>	Current fall time	(see Figure 22)	-	62	-	ns
t <sub>c(off)</sub>	Crossing time		-	11	-	ns

Table 7. Source drain diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current		_		12	Α
I <sub>SDM</sub>	Source-drain current (pulsed)		_		48	Α
V <sub>SD</sub> <sup>(1)</sup>	Forward on voltage	I <sub>SD</sub> = 12 A, V <sub>GS</sub> =0	-		1.5	V
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 12 A, V <sub>DD</sub> = 60 V	ı	444		ns
$Q_{rr}$	Reverse recovery charge	$di/dt = 100 A/\mu s$ ,	-	7		μС
I <sub>RRM</sub>	Reverse recovery current	(see Figure 21)	1	32		Α
t <sub>rr</sub>	Reverse recovery time	I <sub>SD</sub> = 12 A,V <sub>DD</sub> = 60 V	ı	630		ns
Q <sub>rr</sub>	Reverse recovery charge	di/dt=100 A/μs, Tj=150 °C <i>(see</i>	-	9.2		μC
I <sub>RRM</sub>	Reverse recovery current	Figure 21)	-	29		Α

<sup>1.</sup> Pulsed: pulse duration =  $300\mu$ s, duty cycle 1.5%

Table 8. Gate-source Zener diode

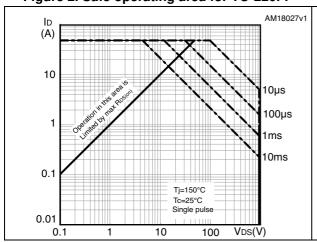
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)GSO</sub>	Gate-source breakdown voltage	$I_{GS}$ = ± 1 mA, $I_D$ = 0	30	-	-	V

The built-in back-to-back Zener diodes have specifically been designed to enhance not only the device's ESD capability, but also to make them safely absorb possible voltage transients that may occasionally be applied from gate to source. In this respect the Zener voltage is appropriate to achieve an efficient and cost-effective intervention to protect the device's integrity. These integrated Zener diodes thus avoid the usage of external components.

### 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area for TO-220FP

Figure 3. Thermal impedance for TO-220FP



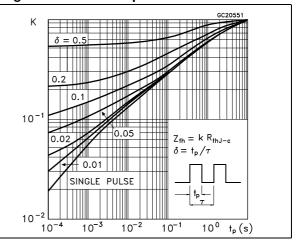
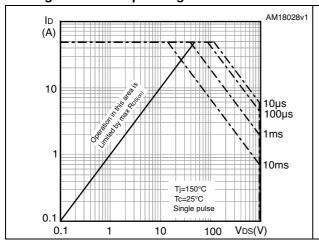


Figure 4. Safe operating area for TO-220

Figure 5. Thermal impedance for TO-220



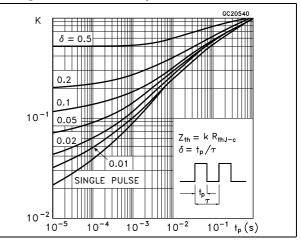
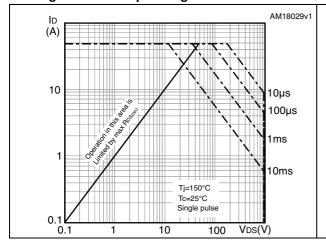


Figure 6. Safe operating area for TO-247

Figure 7. Thermal impedance for TO-247



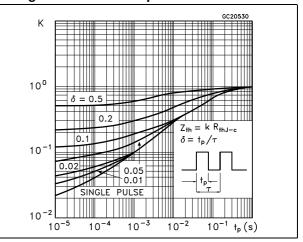


Figure 8. Output characteristics

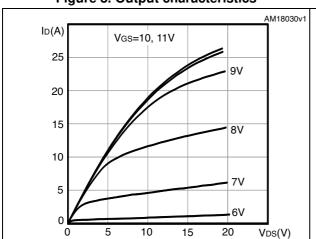


Figure 9. Transfer characteristics

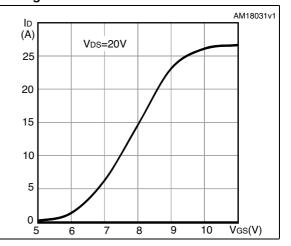
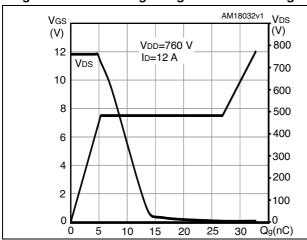


Figure 10. Gate charge vs gate-source voltage

Figure 11. Static drain-source on-resistance



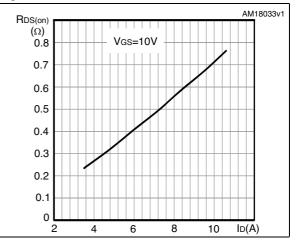
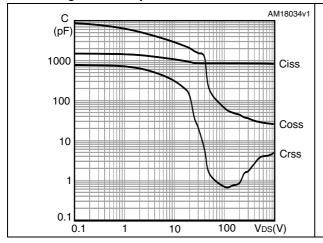


Figure 12. Capacitance variations

Figure 13. Output capacitance stored energy



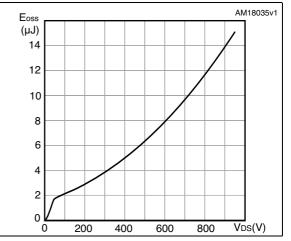


Figure 14. Normalized gate threshold voltage vs temperature

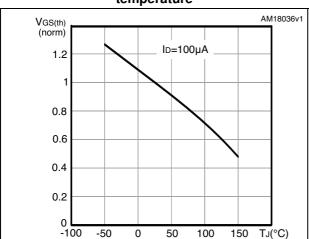


Figure 15. Normalized on-resistance vs temperature

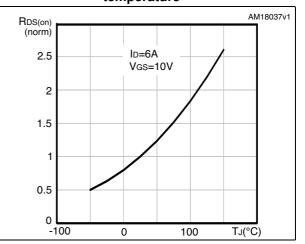
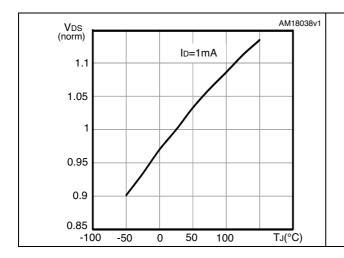


Figure 16. Normalized  $V_{\text{DS}}$  vs temperature

Figure 17. Source-drain diode forward characteristics



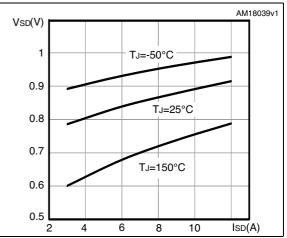
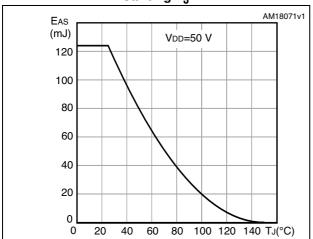


Figure 18. Maximum avalanche energy vs starting T<sub>.I</sub>



### 3 Test circuits

Figure 19. Switching times test circuit for resistive load

Figure 20. Gate charge test circuit

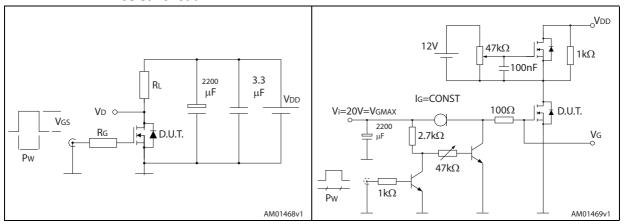


Figure 21. Test circuit for inductive load switching and diode recovery times

Figure 22. Unclamped inductive load test circuit

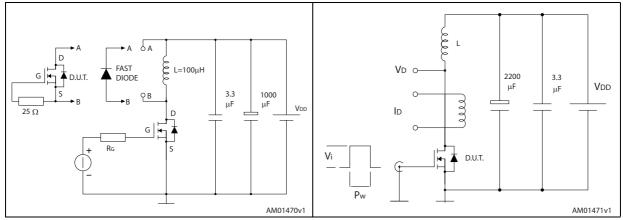
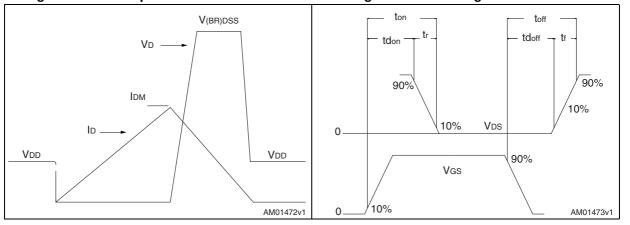


Figure 23. Unclamped inductive waveform

Figure 24. Switching time waveform



# 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.

-*B*-Dia L6 L2 *L7* L3 F1 **L4** F2 Ε -G1\_ 7012510\_Rev\_K\_B

Figure 25. TO-220FP drawing

Table 9. TO-220FP mechanical data

mm				
Dim.			Τ	
	Min.	Тур.	Max.	
А	4.4		4.6	
В	2.5		2.7	
D	2.5		2.75	
E	0.45		0.7	
F	0.75		1	
F1	1.15		1.70	
F2	1.15		1.70	
G	4.95		5.2	
G1	2.4		2.7	
Н	10		10.4	
L2		16		
L3	28.6		30.6	
L4	9.8		10.6	
L5	2.9		3.6	
L6	15.9		16.4	
L7	9		9.3	
Dia	3		3.2	

øΡ H1 D <u>D1</u> L20 L30 <u>L</u>1 b1(X3) b (X3) .e 1\_ 0015988\_typeA\_Rev\_T

Figure 26. TO-220 type A drawing

Table 10. TO-220 type A mechanical data

Dim	mm		
Dim.	Min.	Тур.	Max.
Α	4.40		4.60
b	0.61		0.88
b1	1.14		1.70
С	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10		10.40
е	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13		14
L1	3.50		3.93
L20		16.40	
L30		28.90	
ØP	3.75		3.85
Q	2.65		2.95

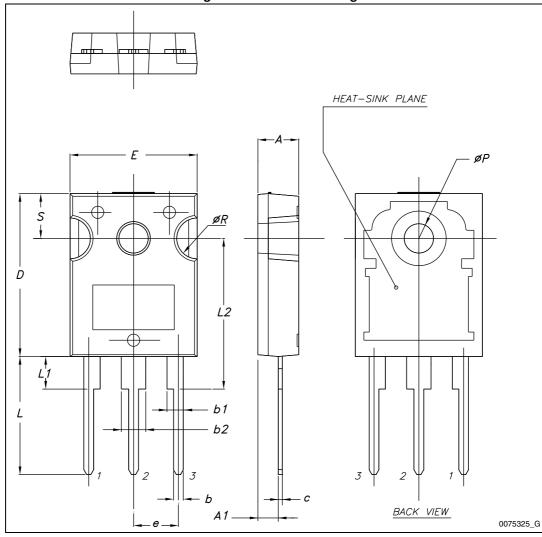


Figure 27. TO-247 drawing

Table 11. TO-247 mechanical data

Dim.	mm.			
	Min.	Тур.	Max.	
Α	4.85		5.15	
A1	2.20		2.60	
b	1.0		1.40	
b1	2.0		2.40	
b2	3.0		3.40	
С	0.40		0.80	
D	19.85		20.15	
E	15.45		15.75	

Table 11. TO-247 mechanical data (continued)

Dim.	mm.			
	Min.	Тур.	Max.	
е	5.30	5.45	5.60	
L	14.20		14.80	
L1	3.70		4.30	
L2		18.50		
ØP	3.55		3.65	
ØR	4.50		5.50	
S	5.30	5.50	5.70	

# 5 Revision history

**Table 12. Document revision history** 

Date	Revision	Changes
20-Sep-2013	1	First release.
07-Feb-2014	2	<ul> <li>Modified: I<sub>AR</sub> and E<sub>AS</sub> values in <i>Table 2</i></li> <li>Added: note 4 in <i>Table 2</i></li> <li>Modified: R<sub>thj-case</sub> values in <i>Table 3</i></li> <li>Modified: typical values in <i>Table 5</i>, 6 and 7</li> <li>Added: Section 2.1: Electrical characteristics (curves)</li> <li>Updated: Figure 19, 20, 21 and 22</li> <li>Minor text changes</li> </ul>

#### Please Read Carefully:

Information in this document is provided solely in connection with ST products. STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, modifications or improvements, to this document, and the products and services described herein at any time, without notice.

All ST products are sold pursuant to ST's terms and conditions of sale.

Purchasers are solely responsible for the choice, selection and use of the ST products and services described herein, and ST assumes no liability whatsoever relating to the choice, selection or use of the ST products and services described herein.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted under this document. If any part of this document refers to any third party products or services it shall not be deemed a license grant by ST for the use of such third party products or services, or any intellectual property contained therein or considered as a warranty covering the use in any manner whatsoever of such third party products or services or any intellectual property contained therein.

UNLESS OTHERWISE SET FORTH IN ST'S TERMS AND CONDITIONS OF SALE ST DISCLAIMS ANY EXPRESS OR IMPLIED WARRANTY WITH RESPECT TO THE USE AND/OR SALE OF ST PRODUCTS INCLUDING WITHOUT LIMITATION IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE (AND THEIR EQUIVALENTS UNDER THE LAWS OF ANY JURISDICTION), OR INFRINGEMENT OF ANY PATENT, COPYRIGHT OR OTHER INTELLECTUAL PROPERTY RIGHT.

ST PRODUCTS ARE NOT DESIGNED OR AUTHORIZED FOR USE IN: (A) SAFETY CRITICAL APPLICATIONS SUCH AS LIFE SUPPORTING, ACTIVE IMPLANTED DEVICES OR SYSTEMS WITH PRODUCT FUNCTIONAL SAFETY REQUIREMENTS; (B) AERONAUTIC APPLICATIONS; (C) AUTOMOTIVE APPLICATIONS OR ENVIRONMENTS, AND/OR (D) AEROSPACE APPLICATIONS OR ENVIRONMENTS. WHERE ST PRODUCTS ARE NOT DESIGNED FOR SUCH USE, THE PURCHASER SHALL USE PRODUCTS AT PURCHASER'S SOLE RISK, EVEN IF ST HAS BEEN INFORMED IN WRITING OF SUCH USAGE, UNLESS A PRODUCT IS EXPRESSLY DESIGNATED BY ST AS BEING INTENDED FOR "AUTOMOTIVE, AUTOMOTIVE SAFETY OR MEDICAL" INDUSTRY DOMAINS ACCORDING TO ST PRODUCT DESIGN SPECIFICATIONS. PRODUCTS FORMALLY ESCC, QML OR JAN QUALIFIED ARE DEEMED SUITABLE FOR USE IN AEROSPACE BY THE CORRESPONDING GOVERNMENTAL AGENCY.

Resale of ST products with provisions different from the statements and/or technical features set forth in this document shall immediately void any warranty granted by ST for the ST product or service described herein and shall not create or extend in any manner whatsoever, any liability of ST.

ST and the ST logo are trademarks or registered trademarks of ST in various countries.

Information in this document supersedes and replaces all information previously supplied.

The ST logo is a registered trademark of STMicroelectronics. All other names are the property of their respective owners.

© 2014 STMicroelectronics - All rights reserved

STMicroelectronics group of companies

Australia - Belgium - Brazil - Canada - China - Czech Republic - Finland - France - Germany - Hong Kong - India - Israel - Italy - Japan - Malaysia - Malta - Morocco - Philippines - Singapore - Spain - Sweden - Switzerland - United Kingdom - United States of America

www.st.com

18/18 DocID025280 Rev 2